

**Search Notes**

Application/Control No.

10/790,583

Examiner

Jinhee J. Lee

Applicant(s)/Patent under  
Reexamination

WIEKHORST ET AL.

Art Unit

2831

**SEARCHED**

Class	Subclass	Date	Examiner
174	117as	3/30/2005	LEE
"	113as	3/30/2005	"
"	110r	3/30/2005	"
174	as above	10/2/2006	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
174	as above	3/30/2005	Lee

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Chau Nguyen	3/29/2005	LEE
East text search attached	3/30/2005	LEE
Updated search attached	9/23/2005	LEE